

Impact of neutron induced ex-situ defects on the properties of CCs and their thermal stability

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P. Gao et al., AIP Advances **7** (2017) 035215

- position enables introduction of many defects close to the planes
- defects are small in comparison to coll. cascades
- defects may be modelled with MDS



Irradiation influences performance



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Background

- what values do we actually determine J_c , n value, T_c
- how does irradiation influence those parameters

Methods

- neutron irradiation techniques
- Gd neutron capture process
- introduced defects molecular dynamics simulations (MDS & DFT)

Results

- decrease of $T_{\rm c}$ and superfluid density
- degradation of the irreversibility line
- Recovery of T_c by annealing

Conclusions





Background





Concerning J_{c}





Concerning J_{c}





Concerning J_{c}





$$E_{\rm c} = \frac{1}{\lambda^2 \xi^2} = \frac{1}{\lambda^2} H_{\rm c2}$$
$$n = \frac{U_0}{k_B T} \qquad \frac{1}{\lambda^2} = \rho_s$$

$$U_0 \propto E_c$$
$$E_c = \rho_s \frac{1}{\xi_0 l}$$

$$J_d \propto \frac{H_c}{\lambda} \propto \frac{1}{\lambda^2 \xi} \propto \sigma_{dc} T_c \propto \eta^{-1} J_c^p$$

 $\rho_{\rm s}$... superfluid density $\sigma_{dc} = \rho_{dc}^{-1}$... normal state conductivity ξ_0 ... clean limit coherence length *l* ... mean free path E_c ... condensation energy U_0 ... pinning energy η ... pinning efficience



$$E_{\rm c} = \frac{1}{\lambda^2 \xi^2} = \frac{1}{\lambda^2} H_{\rm c2}$$
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 $\rho_{\rm s}$... superfluid density

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What's important here E_c condensation energy $E_c = \rho_s \frac{1}{\xi_0 l}$ U_0 ... pinning energy

 η ... pinning efficience

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- E_c ... condensation energy
- U_0 ... pinning energy
- η ... pinning efficience

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$\frac{1}{\lambda^2} = \rho_s \qquad U_0 \propto E_c$ Very simplified

o_s ... superfluid density

 $\sigma_{dc} = \rho_{dc}^{-1}$... normal state conductivity

 ξ_0 ... clean limit coherence length

$\rho_s \propto T_c \propto E_c \propto n \propto J_d \propto J_c^p \eta^{-1}$

 $\boldsymbol{J_d} \propto \frac{H_c}{\lambda} \propto \frac{1}{\lambda^2 \xi} \propto \sigma_{dc} \boldsymbol{T_c} \propto \eta^{-1} \boldsymbol{J_c^p}$

 U_0 ... pinning energy

 η ... pinning efficience

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Background - T_c degradation

scattering is pair breaking in *d*-wave superconductors

- decrease of transition temperature, T_c
- decrease of superfluid density, ρ_s



Background – *n*-value degradation



- n value degrades linearly with $T_{\rm c}$
- degradation of condensation energy reduces T_c , I_c and n
- n degrades with the same slope for completely different defect landscapes









^{*}drawing assumes constant n







Methods



Two nearly identical samples



- SuperPower 2009 no APC
- sample consistency checked by hall scans
- profile at self-field & 77 K
- voltage taps in low defect areas

Two nearly identical samples



- two nearly identical pristine samples
- Gd-123 tape from SuperPower (2009) no APCs
- irradiated with and without Cd-screen
- difference: number of displaced Gd-atoms

Neutron irradiation – sample 1

TRIGA MARK II at TU Wien

- irradiation in the central irradiation facility
- fast / thermal neutron flux 3.2 / 4 x 10¹⁶ m⁻² s⁻¹
- irradiation with and without thermal (< 0.55 eV) neutrons



< 70 C at sample



TRIGA MARK II – experimental fission reactor

Defect structure



left – TEM picture of neutron induced defects **right** – FFT of selected regions ¹

Only large defects visible in TEM

0.3

[1] with friendly permission by Yatir Linden, *Analysing neutron radiation damage in YBa2Cu3O7–x high-temperature superconductor tapes*, <u>https://doi.org/10.1111/jmi.13078</u> Department of Materials, University of Oxford, Oxford, UK

Neutron irradiation – sample 2

TRIGA MARK II at TU Wien

- irradiation in the central irradiation facility
- fast / thermal neutron flux 3.2 / 4 x 10¹⁶ m⁻² s⁻¹
- irradiation with and without thermal (< 0.55 eV) neutrons



< 70 C at sample



TRIGA MARK II – experimental fission reactor





K.E. Sickafus et al., Phys. Rev. B 46 (1992) 11862

- thermal neutrons excite Gd —> emission of gamma displaces the nucleus
- very high defect densities achievable
- add to fast neutron induced defects



What defects do we introduce?

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MD simulations



- different defects originating from Gd PKA (primary knock on atom)
- calculate expected defect distribution
- calculate DOS close to the Fermi-energy
 - estimate influence on superconducting properties

MD... molecular dynamics DFT... density-functional theory

MD simulations



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DFT calculations



- different defects originating from Gd PKA (primary knock on atom)
- calculate expected defect distribution
- calculate DOS close to the Fermi-energy
 - estimate influence on superconducting properties

* consistency of DFT calculation confirmed with exp. data Cu substitution by Fe, Zn & Ni



Results



Influence of thermal neutrons - T_c



 $T_{\rm c}$ degrades ~13-15 x faster due to Gd-point defects



\square Influence of thermal neutrons - J_c



- maximum occurs at much lower neutron fluences
- *J*_c at maximum is smaller
- degradation is much faster

\square Influence of thermal neutrons - J_c



\square Influence of thermal neutrons - J_c





shielded sample

unshielded sample





shielded sample

unshielded sample



 shielded peak is at lower fields at "matching" field unshielded peak is broad and at higher fields



shielded sample

unshielded sample



 shielded peak is at lower fields at "matching" field unshielded peak is broad and at higher fields



shielded sample



unshielded sample

- more degradation at higher fields
- secondary defects?

 degrading effect more homogeneous less field dependent



shielded sample

unshielded sample



- more degradation at higher fields
- secondary defects?

 degrading effect more homogeneous less field dependent



What's leading to this almost equivalent degradation?





$$B_{\rm irr}({\rm T}) = \boldsymbol{B}_{irr}(\boldsymbol{0}) \times \left(1 - \frac{T}{T_{\rm c}}\right)^n$$
 applied fit function

bold – fit parameters

Can't we just blame the irreversibility field?





$$B_{\rm irr}({\rm T}) = \boldsymbol{B}_{irr}(\boldsymbol{0}) \times \left(1 - \frac{T}{T_{\rm c}}\right)^n$$
 applied fit function

bold – fit parameters

Can we trust this interpolation?

fit is extrapolated quite far however trend is probably valid





- in shielded sample B_{irr} at 30 K is still at or above pristine value
- in unshielded sample B_{irr} is degraded to ~ 80% of pristine value

 \implies B_{irr} behaves completely different in both samples degradation of J_c at 15 T and 30 K is the same ~ 70% of pristine value

Homogeneous degradation

How can we (try to) explain it then?

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Homogeneous degradation



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Homogeneous degradation



Thermal stability of small vs large defects



- $T_{\rm c}$ regenerates linearly with $T_{\rm a}$
- all neutron irradiated samples anneal to same point
- annealing defects have same/similar distribution and activation barrier.
- n_{therm}, n_{fast} & p⁺ irradiated samples



Conclusions

Simulation results:

- from MDS dominant defect species are O₂ vacancies.
- Gd antisites are 500:1 less probable, however calculation of DOS indicates strong suppression at E_F

Experimental results:

- small defects contribute to pinning at large fields and low temperatures
- position of maximum in J_c is dependent on defect density independent of irradiation technique (p⁺, n_{therm}, n_{fast})
- suppression of J_c at high fluences and fields almost equivalent (n_{therm} vs n_{fast})
- annealing indicates that degradation comes from same defect class

Seems to confirm that O_2 interstitials are the driving force in the degradation



Homes' scaling law



- though logarithmic, the superfluid density scales with σ_{dc} and T_{c}
- many orders of magnitude
- many different materials



Thermal stability of small vs large defects





$$B_{irr}(T) = \boldsymbol{B}_{irr}(\mathbf{0}) \times \left(1 - \frac{T}{T_c}\right)^n$$
 applied fit function
bold – fit parameters

shielded tape

- irreversibility line changes slope •
 - at low fluences --> increases
 - at high fluences → decreases ۲

unshielded tape

• irreversibility line keeps slope





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Does the degradation of B_{irr} explain the low J_c at 30 K?



Can't we just blame the irreversibility field?

No.

$$B_{\rm irr}({\rm T}) = \boldsymbol{B}_{irr}(\boldsymbol{0}) \times \left(1 - \frac{T}{T_{\rm c}}\right)^n$$
 applied fit function

bold – fit parameters



Homes' scaling law

$$ho_{
m s} \propto \sigma_{
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 $\rho_{\rm s}$... superfluid density

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$$j_{
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m c}}{\lambda} \propto rac{1}{\lambda^2 \xi} \propto rac{
ho_{
m s}}{\xi}$$

$$j_{\rm c}^{\,{\rm p}}=\eta\;j_{
m d}$$

 η ... pinning efficiency

 $j_{\rm c}^{\rm p}$... physical critical current

 j_{c} should be proportional to the normal state resistivity